Rest on the the the the the the

Product Name	:	Fanless Multi-Touch PPC
Brand Name	:	AAEON
Model Number	:	ACP-1103xxx-Ax-xxxx (x is 0-9,A-Z ," - "or blank)
Applicant	:	AAEON Technology Inc.
Address	:	5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist.,
		New Taipei City 23145, Taiwan, R.O.C
Report Number	:	F-A600-1307-006
Issue Date	:	August 6, 2013

Applicable Standards : FCC Part 15, Subpart B Class A ITE ANSI C63.4:2009 Industry Canada ICES-003 Issue 5 **CSA-IEC CISPR22-10 Class A ITE**

One sample of the designated product has been tested in our laboratory and found to be in compliance with the FCC rules cited above.





NVLAP LAB CODE 200575-0

TAF 0905 FCC CAB Code TW1053 IC Code 4699A VCCI Accep. No. R-1527, C-1609, T-1441, G-10, C-4400, T-1334, G-614



Central Research Technology Co. **EMC Test Laboratory** 11, Lane41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. Tel: 886-2-25984568 Fax: 886-2-25984546

J. Y. Elik

(Tsun-Yu Shih/ General Manager) Date: August 6, 2013

FCC Test Report

for

Fanless Multi-Touch PPC

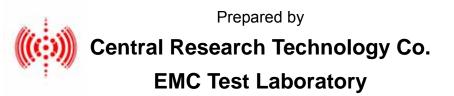
Trade Name	:	AAEON
Model Number	:	ACP-1103xxx-Ax-xxxx
		(x is 0-9,A-Z ," - "or blank)
Report Number	:	F-A600-1307-006
Date of Receipt	:	July 18, 2013
Date of Report	:	August 6, 2013

Prepared for

AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist., New Taipei City 23145,

Taiwan, R.O.C



11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.



NVLAP LAB CODE 200575-0

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Verification of Compliance

Equipment Under Test	: Fanless Multi-Touch PPC		
Model No.	: ACP-1103xxx-Ax-xxxx (x is 0-9,A-Z ," - "or blank)		
Applicant	: AAEON Technology Inc.		
Address : 5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien Dis			
	New Taipei City 23145, Taiwan, R.O.C		
Applicable Standards	: FCC Part 15, Subpart B Class A ITE		
	ANSI C63.4:2009		
	Industry Canada ICES-003 Issue 5		
	CSA-IEC CISPR22-10 Class A ITE		
	HC.		

Date of Testing	: July 19~30, 2013
Deviation	: N/A
Condition of Test Sample	: Engineering Sample

We, **Central Research Technology Co**., hereby certify that one sample of the designated product was tested in our facility during the period mentioned above. The test records, data evaluation and Equipment Under Test (EUT) configurations shown in the present report are true and accurate representation of the measurements of the sample's EMC characteristics under the conditions herein specified.

The test results show that the EUT as described in the present report is in compliance with the requirements set forth in the standards mentioned above and apply to the tested sample identified in the present report only. The test report shall not be reproduced, except in its entirety, without the written approval of Central Research Technology Co.

PREPARED BY	:	In	3 0	L-	· DATE :	Aug. 6, 2013
		(Iris Chen	/System	n Executive)	5 S	0
APPROVED BY	:	√.	Υ.	?l:l_	_ , DATE : _	Aug. 6, 2013
		(Tsun-Yu	Shih/Ge	eneral Manage	r)	U

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1. General Description

1.1 General Description of EUT

Equipment Under Test	:	: Fanless Multi-Touch PPC				
Model No.	:	: ACP-1103xxx-Ax-xxxx (x is 0-9,A-Z ," - "or blank)				
Power in	:	: Supplied by the power adapter				
Power Adapter Specification	:	Trade Name	:	FSP		
		Model No.	:	FSP060-DBAE1		
		Input	:	100-240V~ 1.5A, 50-60Hz		
		Output	:	12Vdc, 5A Max		
Highest Operating Frequency	:	1.6GHz from	the	test specification		
Manufacturer	:	AAEON Tech	nolo	ogy Inc.		
Function Description	:					

The EUT is an engineering sample of the Fanless Multi-Touch PPC. Please refer to the user's manual for the details.

The I/O ports of EUT are listed below:

No.	I/O Port Type	Quantity
1	RS232 / RS422 / RS485 port	3
2	USB port	4
3	LAN port	1
4	MINI HDMI port	1

1.2 Test Mode

The Resolution 1280*800@75Hz was selected by its manufacturer to perform all tests. It was taken as the representative condition for testing and its data are recorded in the present document.

1.3 Applied standards

According to the specifications of the manufacturer and the requirements set in 47CFR Part 15, the applied standards to evaluate the compliance of the EUT are as following, and the measurement procedures specified in ANSI C63.4: 2009 are performed.

According to 47CFR Part 15 Section 15.33(b), the test frequency range of radiated emission measurements are listed below and the EUT herein shall be tested as:

Type of EUT	Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
	Below 1.705	30
	1.705 - 108	1000
	108 - 500	2000
	500 - 1000	5000
		5 th harmonic of the highest
\checkmark	Above 1000	frequency or 40GHz,
		whichever is lower

All the test items are as following:

Applied Standards	Test Items	Results
FCC Part 15, Subpart B	☑ Conducted Emission Measurement	PASS
Class A ITE	☑ Radiated Emission Measurement	PASS

1.4 Test Setup for the EUT

The EUT is an unique unit connected with other necessary accessories and support units listed in the next section. It has been tested against each standard after the following steps:

- a. Connect the EUT and all the support units to the appropriate power source.
- b. Turn on the EUT and all the accessories and support units.
- c. The EUT load an EMC test software and execute it under the Windows environment.
- d. The EUT sends "H" patterns to the monitor, which fills the whole screen of it.
- e. The EUT reads/writes messages from/to USB Flash Disk continuously.
- f. The EUT sends message to modem.
- g. Another PC sends/receives messages to/from the EUT through a Hub by executing the command of "PING".
- h. Repeat and keep the setup steps listed above before and during all tests.

EUT I/O ports / Peripherals	Exerciser Program (software)	Version of Program	
EUT			
Monitor	BurnIn Test.exe	V 7.0	
USB Flash Disk			
Modem			

1.5 The Support Units

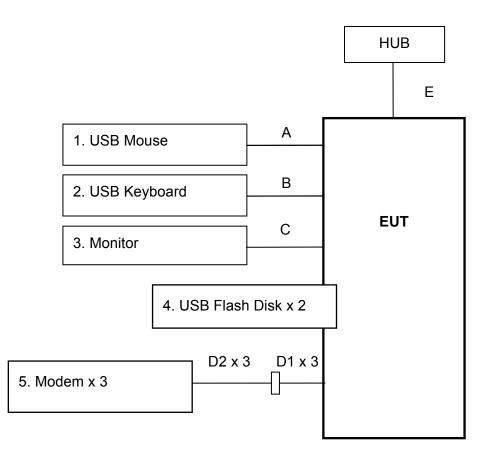
Conducted Emission Test

No.	Unit	Model No.	FCC ID	Trade Name	Power Cord	Supported by lab.
1	USB Mouse	MO56UC	DoC	DELL	N/A	✓
2	USB Keyboard	SK-8115	DoC	DELL	N/A	✓
3	Monitor	U2410	DoC	DELL	1.8m	✓
4	USB Flash Disk	U172	DoC	PQI	N/A	✓
5	Modem	DM-1414	IFAXDM1414	ACEEX	1.8m	~

Radiated Emission Test

No.	Unit	Unit Model No.	FCC ID	Trade	Power	Supported
NO.	Onic	Model No.	FCCID	Name	Cord	by lab.
1	USB Mouse	MS111-P	N/A	DELL	N/A	\checkmark
2	USB Keyboard	SK-8115	DoC	DELL	N/A	✓
3	Monitor	U2410	DoC	DELL	1.8m	✓
4	USB Flash Disk	U172	DoC	PQI	N/A	✓
5	Modem	DM-1414	IFAXDM1414	ACEEX	1.8m	\checkmark

1.6 Layout of the Setup



Connecting Cables :

No.	Cable	Length	Shielded	Core	Shielded Backshell	Supported by lab.	Note
А	USB Mouse Cable	1.8m	~			~	
В	USB Keyboard Cable	1.8m	✓			~	
С	Mini HDMI to HDMI Cable	2.0m	✓			~	
D1	RS232 Cable	0.16m	✓				
D2	RSZSZ Cable	1.8m	✓	✓		~	2 cores
Е	LAN Cable	1.8m				~	

1.7 Test Capability

Test Facility

The test facility used for evaluating the conformance of the EUT with each standard in the present report meets what required in CISPR16-1-4, CISPR16-2-3 and ANSI C63.4: 2009.

Test Room	Type of Test Room	Descriptions
TR1	10m semi-anechoic chamber ($23m \times 14m \times 9m$)	Complying with the NSA and the site VSWR requirements in documents
TR1	$3m$ fullly-anechoic chamber (2 $3m \times 14m \times 9m$)	CISPR 22 and ANSI C63.4: 2009. for the radiated emission measurement.
TR11	3m semi-anechoic chamber (9m × 6m × 6m)	Complying with the NSA requirements in documents CISPR 22 for the radiated emission measurement.
TR5	Shielding Room (8m × 5m × 4m)	For the conducted emission
TR4	Shielding Room (5m×3m×3m)	measurement.

Test Laboratory Competence Information

Central Research Technology Co. has been accredited / filed / authorized by the agencies listed in the following table.

Certificate	Nation	Agency	Code	Mark
	USA	NVLAP	200575-0	ISO/IEC 17025
	R.O.C. (Taiwan)	TAF	0905	ISO/IEC 17025
Accreditation Certificate	R.O.C. (Taiwan)	BSMI	SL2-IN-E-0033, SL2-IS-E-0033, SL2-R1/R2-E-0033, SL2-A1-E-0033 SL2-L1-E-0033	ISO/IEC 17025
	USA	FCC	474046,TW1053	Test facility list & NSA Data
Site Filing Document	Canada	IC	4699A-1,-3	Test facility list & NSA Data
	Japan	VCCI	R-1527,C-1609, C-4400, T-1441, T-1334, G-10, G-614	Test facility list & NSA Data
Authorization	Germany	TUV	10021687	ISO/IEC 17025
Certificate	Norway	Nemko	ELA 212	ISO/IEC 17025

The copy of each certificate can be downloaded from our web site: www.crc-lab.com

2. Conducted Emission Measurement

Test Result : PASS

2.1 Limits for Emission Measurement

☑ Limits for conducted disturbances at the power mains

Frequency (MHz)	Class A E	Class A Equipment		quipment	
	Quasi-peak	Average	Quasi-peak	Average	
(11112)	(dBµV)	(dBµV)	(dBµV)	(dBµV)	
0.15 to 0.5	79	66	66 – 56	56 – 46	
0.5 to 5	73	60	56	46	
5 to 30	73	60	60	50	
Note 1- The lower limit shall apply at the transition frequency.					
Note 2- The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to					
0.5MHz for Class B equipment.					

2.2 Test Instruments

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Manufacturer	Serial No.	Calibration Date	Due Date	
Test Receiver	R&S	ESCS 30/	Jan. 14, 2013	lon 14 2014	
Test Receiver	κασ	836858/021	Jan. 14, 2013	Jan. 14, 2014	
LISN	R&S	ESH2-Z5/	March 15, 2013	March 15, 2014	
LIGIN	κασ	880669/039	Warch 15, 2015	Walch 15, 2014	
2 nd LISN	R&S	ENV4200/	March 29, 2013	March 20, 2014	
2 LISIN	Rao	833209/010	Warch 29, 2013	March 29, 2014	
50Ω terminator	N/A	N/A/		Aug 20 2012	
	N/A	001	Aug. 20, 2012	Aug. 20, 2013	
RF Switch	R&S	RSU28/	Feb. 19, 2013	Aug. 19, 2013	
	Ras	338965/002	Feb. 19, 2013	Aug. 19, 2013	
RF Cable	N/A	N/A/	Feb. 19, 2013	Aug. 19, 2013	
RF Cable	N/A	C0052 ~ 56	Feb. 19, 2013	Aug. 19, 2013	
Test Software	Audix	e3/	NCR	NCR	
	Audix	Ver. 5.2004-2-19k	NCK	NCK	
TR5	ETS	TR5/	NCR	NCR	
shielded room	LINDGREN	15353-F			

Note:

1. The calibrations are traceable to NML/ROC.

2. NCR : No Calibration Required.

Measurement Uncertainty

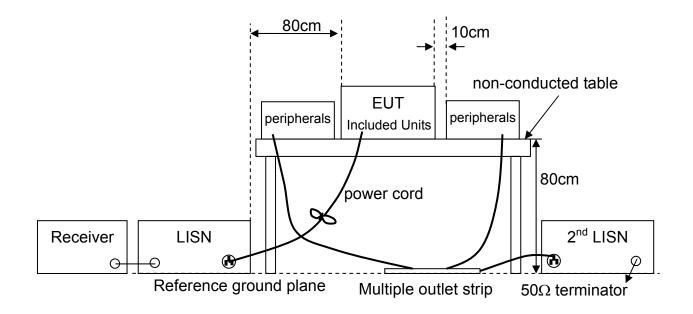
The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than U_{cispr} in table 1 of CISPR 16-4-2.

Equipment	Model Number	Uncertainty Value
LISN	ESH2-Z5	3.1dB
LISIN	ENV 4200	2.7dB

2.3 Test Procedures

- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a non-conducted table with a height of 0.8 meters above the reference ground plane and 0.4 meters from the conducting wall of the shielded room. Also if the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 12 millimeters above the reference ground plane.
- c. Connect the EUT's power source to the appropriate power mains through the LISN.
- d. All the other peripherals are connected to the 2nd LISN, if any.
- e. The LISN was placed 0.8 meters from the EUT and at least 0.8 meters from other units and other metal planes.
- f. Measure the conducted emissions on each power line (Neutral Line and Line 1 Hot side) of the EUT's power source by using the test receiver connected to the coupling RF output port of LISN.
- g. Rapidly scan the signal from 150kHz to 30MHz by using the receiver through the Maximum-Peak detector to determine those frequencies associated with higher emission levels for each measured line.
- h. Then measure the maximum level of conducted disturbance for each frequency found from step g. by using the receiver through the Quasi-Peak and Average detectors per CISPR 16-1.
- i. Record the level for each frequency and compare with the required limit.

2.4 Test Configurations



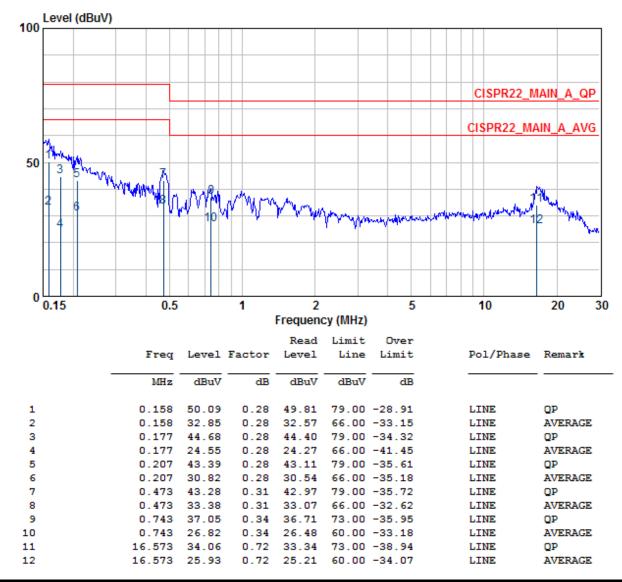
2.5 Photographs of the Test Configurations





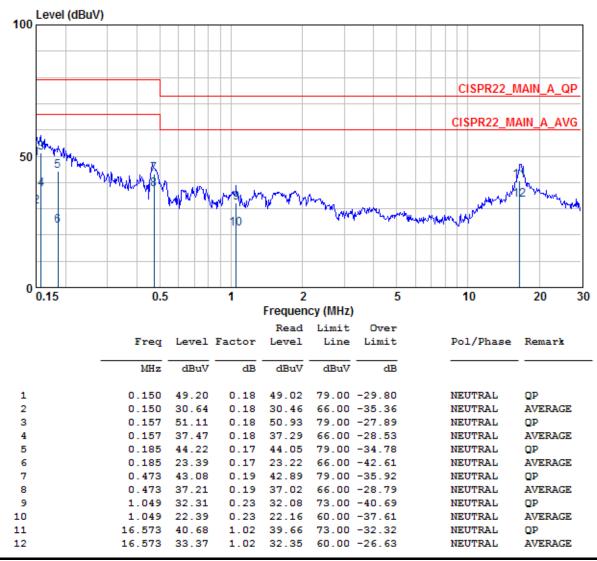
2.6 Test Results

Test Mode	:	As description of section 1.2			
Test Voltage	:	120V/60Hz to the power adapter			
Tester	:	Kent	Temperature	:	26°C
Humidity	:	68%RH	Frequency Range	:	150kHz~30MHz
IF Bandwidth	:	9kHz	Phase	:	Line



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.

Test Mode	:	As description of section 1.2			
Test Voltage	:	120V/60Hz to the power adapter			
Tester	:	Kent	Temperature	:	26°C
Humidity	:	68%RH	Frequency Range	:	150kHz~30MHz
IF Bandwidth	:	9kHz	Phase	:	Neutral



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.

3. Radiated Emission Measurement

Test Result : PASS

3.1 Limits for Emission Measurement

☑ Limits for radiated disturbances below 1000MHz

Frequency	Class A Equipment (10m distance)	Class B Equipment (3m distance)		
(MHz)	Quasi-peak	Quasi-peak		
	(dBµV/m)	(dBµV/m)		
30 to 88	39.1	40		
88 to 216	43.5	43.5		
216 to 960	46.4	46		
960 to 1000	49.5	54		
Note 1- The lower limi	t shall apply at the transition frequency.			
Note 2- Additional pro	visions may be required for cases where	e interference occurs.		
Note 3- According to 7	15.109(g), as an alternative to the radiat	ed emission limits shown above, digital		
devices may be shown to comply with the standards (CISPR), Pub. 22 shown as below.				
30 to 230	40	30		
230 to 1000	47	37		

☑ Limits for radiated disturbances above 1000MHz at a measuring distance of 3m

Frequency	Class A Ec	quipment	Class B Equipment	
(GHz)	Peak	Average	Peak	Average
(0112)	(dBµV/m)	(dBµV/m)	(dBµV/m)	(dBµV/m)
1 to 40	80	60	74	54

3.2 Test Instruments

☑ For Measurement below 1000MHz

Test Site and	Manufacturer	Model No./	Last	Calibration
Equipment	Manufacturer	Serial No.	Calibration Date	Due Date
EMI Test Receiver	R&S	ESCS 30/ 836858/020	Sept. 10, 2012	Sept. 10, 2013
Broadband Antenna	R&S	HL-562/ 360543/007	March 27, 2013	March 27, 2014
Broadband Antenna	R&S	HL-562/ 830547/010	April 30, 2013	April 30, 2014
Pre-Amplifier	Mini Circuit	ZKL-2/ 001	July 15, 2013	Jan. 15, 2014
Pre-Amplifier	Mini Circuit	ZKL-2/ 002	July 15, 2013	Jan. 15, 2014
Spectrum Analyzer	R&S	FSP40/ 100031	July 15, 2013	July 15, 2014
Spectrum Analyzer	R&S	FSP7/ 100384	Jan. 3, 2013	Jan. 3, 2014
RF Cable	JYEBAO	0214/ C0049	July 15, 2013	Jan. 15, 2014
RF Cable	JYEBAO	0214/ C0050	July 15, 2013	Jan. 15, 2014
Test Software	Audix	e3/ Ver. 4.3.714.e	NCR	NCR
TR1 Semi - anechoic Chamber	ETS. LINDGREN	TR1/ 17627-B	May 4, 2013	May 4, 2014

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR : No Calibration Required.
- 3. The calibration date of the semi-anechoic chamber listed above is the date of NSA measurement.

☑ For Measurement above 1000MHz

Test Site and Equipment	Manufacturer	Model No./ Serial No.		Last Calibration Date	Calibration Due Date
Horn Antenna	EMCO	3117/ 00082847		March 5, 2013	March 5, 2014
Bore-sight Antenna Mast	Sunol		TLT2/ 051110-5	NCR	NCR
	кміс 🗆 Р		KMA010180A01/ 99056	Oct. 19, 2012	Oct. 19, 2013
Pre-Amplifier	MITEQ	ব	JS4-00101800- 28-10P/1498979	Dec. 21, 2012	Dec.21, 2013
			JS4-00101800- 28-5A/742309	Dec. 19, 2012	Dec. 19, 2013
Spectrum Analyzer	R&S	FSP40/ 100031		July 15, 2013	July 15, 2014
RF Cable	Suhner	Sucoflex 106P / C0091 + C0092		April 17, 2013	Oct. 17, 2013
Test Software	Audix	e3/ Ver. 4.3.714.e		NCR	NCR
TR1 Fully - anechoic Chamber	ETS. LINDGREN	TR1/ 17627-B		Feb. 23, 2013	Feb. 23, 2014

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR : No Calibration Required.
- 3. The calibration date of the chamber TR1 listed above is the date of site VSWR measurement.

Measurement Uncertainty

The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than U_{cispr} in table 1 of CISPR 16-4-2.

Test Site	Polarization	Frequency Range		
(Measuring distance)	r olarization	30MHz ~200MHz	200MHz ~1000MHz	
TR1(10m)	Horizontal	3.2dB	3.5dB	
	Vertical	3.3dB	3.6dB	
TR11(3m)	Horizontal	3.8dB	4.1dB	
	Vertical	3.3dB	3.7dB	

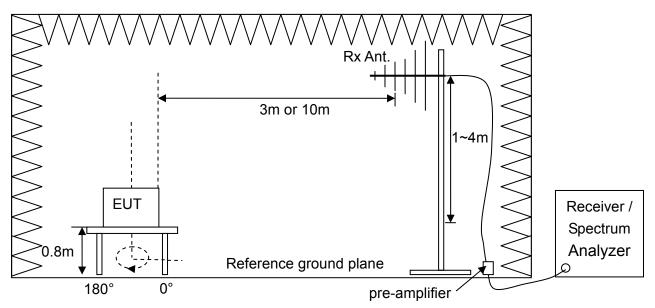
Test Site	Polarization	Frequency Range		
(Measuring distance)	r olarization	1GHz ~18GHz		
TR1(3m)	Horizontal	4.0dB		
	Vertical	3.9dB		

3.3 Test Procedures

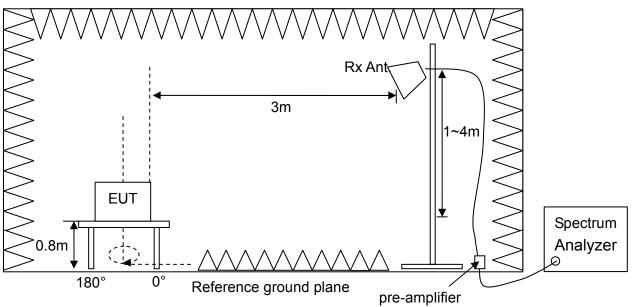
- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a non-conducted table with a height of 0.8 meters above the reference ground plane in the semi-anechoic chamber. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 12 millimeters above the reference ground plane in the semi-anechoic chamber.
- c. For the measurement of frequency below 1000MHz, the EUT was set 10m away from the interference receiving antenna for the limit of Class A equipment or CISPR 22. For Class B equipment and the measurement of frequency above 1000MHz, the EUT was set 3m away from the interference receiving antenna.
- d. Rapidly sweep the signal in the test frequency range by using the spectrum through the Maximum-peak detector.
- e. Rotate the EUT from 0° to 360° and position the receiving antenna at heights from 1 to 4 meters above the reference ground plane continuously to determine at least six frequencies associated with higher emission levels and record them.
- f. For measurement of frequency above 1000MHz, the beamwidth of receiving horn antenna should keep covering EUT when the receiving horn antenna height varied.
- g. Then measure each frequency found from step e. by using the spectrum with rotating the EUT and positioning the receiving antenna height to determine the maximum level.
- h. Finely tune the antenna and turntable around the recorded position of each frequency found from step f.
- i. For measurement of frequency below 1000MHz, set the receiver detector to be Quasi-Peak per CISPR 16-1 to find out the maximum level occurred.
- j. For measurement of frequency above 1000MHz, set the spectrum detector to be Peak or Average to find out the maximum level occurred, if any.
- k. Record frequency, azimuth angle of the turntable, height, and polarization of the receiving antenna and compare the maximum level with the required limit.
- I. Change the receiving antenna to another polarization to measure radiated emission by following step d. to k. again.
- m. If the peak emission level measured from step e. is 4dB lower than the limit specified, then the emission values presented will be the peak value only. Otherwise, accurate Q.P. value will be measured and presented.

3.4 Test Configurations

Radiated Emission Measurement below 1000MHz



Radiated Emission Measurement above 1000MHz





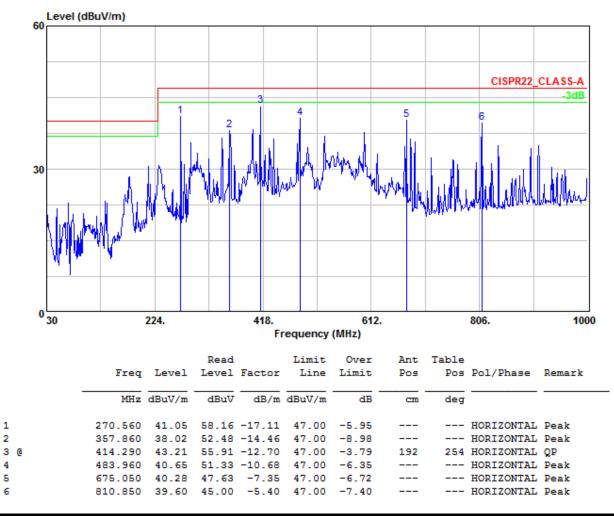
3.5 Photographs of the Test Configurations



3.6 Test Results

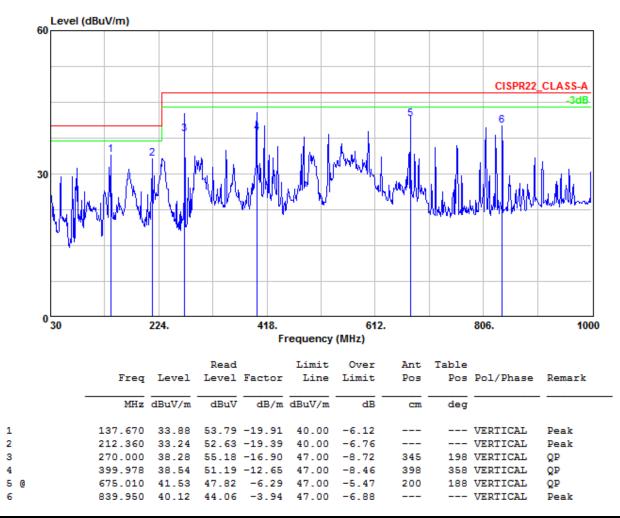
Radiated Emission Measurement below 1000MHz

Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to the power adapter					
Tester	:	Meng	Temperature	:	26°C		
Humidity	:	71%RH	Frequency Range	:	30MHz~1GHz		
IF Bandwidth	:	120kHz	Polarization	:	Horizontal		



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.
- 3. Q.P is abbreviation of quasi-peak.

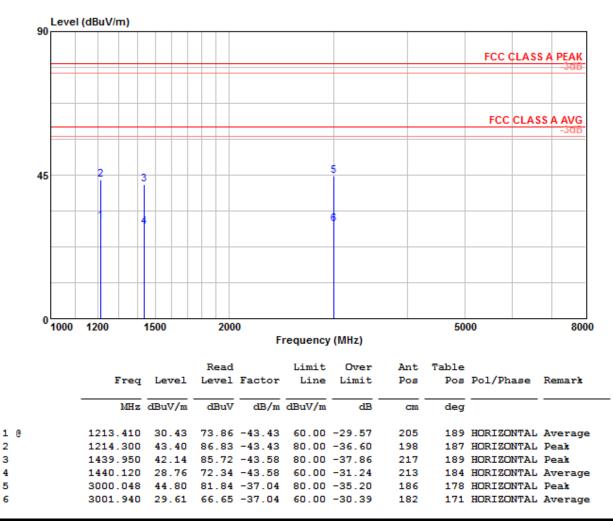
Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to the power adapter					
Tester	:	Meng	Temperature	:	26°C		
Humidity	:	71%RH	Frequency Range	:	30MHz~1GHz		
IF Bandwidth	:	120kHz	Polarization	:	Vertical		



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.
- 3. Q.P is abbreviation of quasi-peak.

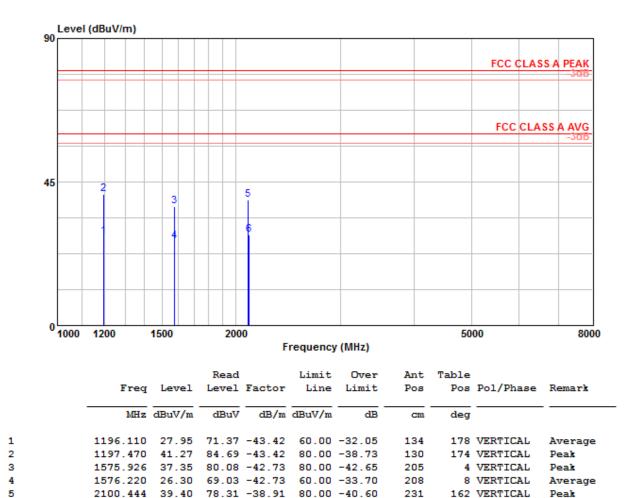
Radiated Emission Measurement above 1000MHz

Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to the power adapter					
Tester	:	Meng	Temperature	:	27°C		
Humidity	:	66%RH	Frequency Range	:	1GHz~8GHz		
IF Bandwidth	:	1MHz	Polarization	:	Horizontal		



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.

Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to the power adapter					
Tester	:	Meng	Temperature	:	27°C		
Humidity	:	66%RH	Frequency Range	:	1GHz~8GHz		
IF Bandwidth	:	1MHz	Polarization	:	Vertical		



Note:

6

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.

2101.730 28.49 67.40 -38.91 60.00 -31.51

Average

155 VERTICAL

239

Attachment 1 Photographs of EUT

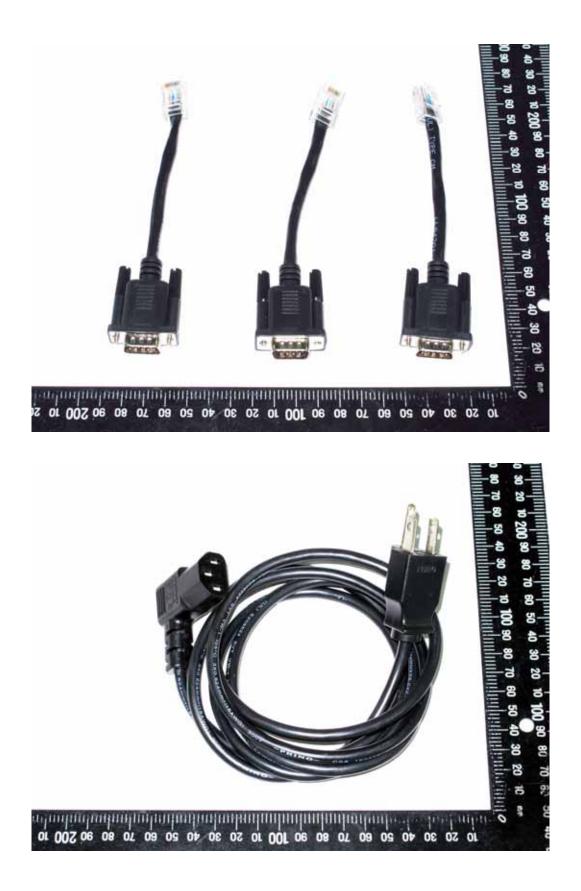












Attachment 2 Modifications of EUT

Statement of the EUT Modifications

According to the rules of ANSI C63.4-2009 clause 10.2.13, the following equipment (EUT):

Product	:	Fanless Multi-Touch PPC
Model No.	:	ACP-1103xxx-Ax-xxxx (x is 0-9,A-Z ," - "or blank)
Manufacturer	:	AAEON Technology Inc.
Address	:	5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist.,
		New Taipei City 23145, Taiwan, R.O.C

□ should be <u>without</u> any modifications made

 \Box should be <u>with</u> some modifications made

to bring the EUT into compliance with the appropriate specifications (47CFR Part 15, Subpart B). If any, the details of the modifications including the complete descriptions, reasons and so on are described in next page of this report.

We , <u>AAEON Technology Inc.</u> hereby ensure that the product specified above will have all of the modifications incorporated in the product when manufactured and placed on the market.

The following importer or manufacturer is responsible for this statement:

Company Name	:		
Company Address	:		
Telephone	:	E-mail:	
Legal Signature of t	the responsible personal:		
Title / Na	ame (full name)		Date

The details of the modifications:

Item	Solution Component	Specifications	Manufacturer	Quantity	Reasons
1					
2					
3					
4					
5					
6					
7					
8					
9					
10					
11					
12					
13					
14					
15					

If needed, some modification items are shown in the photographs in the following.